# Can a Simple Approach Perform Better for Cross-Project Defect Prediction?

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Abstract: Cross-Project Defect Prediction (CPDP) has gained considerable research interest due to the scarcity of historical labeled defective modules in a project. Although there are several approaches for CPDP, most of them contains several parameters that need to be tuned optimally to get the desired performance. Often, higher computational complexities of these methods make it difficult to tune these parameters. Moreover, existing methods might fail to align the shape and structure of the source and target data which in turn deteriorates the prediction performance. Addressing these issues, we investigate correlation alignment for CPDP (CCPDP) and compare it with state-of-the-art transfer learning methods. Rigorous experimentation over three benchmark datasets AEEEM, RELINK and SOFTLAB that include 46 different project-pairs, demonstrate its effectiveness in terms of F1-score, Balance and AUC compared to six other methods TCA, TCA+, JDA, BDA, CTKCCA and DMDA\_JFR. In terms of AUC, CCPDP wins at least 32 and at most 42 out of 46 project pairs compared to all transfer learning based method.

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# **1 INTRODUCTION**

Software Defect Prediction (SDP) has achieved noticeable research attention because an early identification of defects is essential for cost efficient software development and enhanced customer satisfaction. It helps to allocate the testing resources timely and efficiently (Menzies et al., 2010). When a particular project is rich enough with historical labeled defect modules, a traditional classification algorithm can be easily employed for predicting defects in new modules. This process is known as Within Project Defect Prediction (WPDP) (Herbold et al., 2018; Akhter et al., 2023). In reality, due to lack of expertise, time and funding, most of the projects often do not contain previous labeled defective data, and thus, WPDP is less attracted by researchers nowadays. On the other hand, Cross-Project Defect Prediction (CPDP) is a process that does not require project specific historical data. It learns from existing labeled project(s) (source) which is different but related to the project for prediction

(target), that makes CPDP advantageous over WPDP. However, although source and target are related, their distribution may differ due to data collection time, software version, configuration etc. Unfortunately, directly applying traditional classification algorithms do not perform well in such cases.

To solve this issue, filter (Turhan et al., 2009; Peters et al., 2013) and Transfer Learning (TL) based methods (Liu et al., 2019; Qiu et al., 2019; Xu et al., 2019) are usually used for CPDP. Filterbased methods discard the dissimilar instances from the source project considering target instances. In contrast, TL-based methods leverage all instances to identify transformation matrices. These matrices are then utilized to transform either source or target or both data into a separate space to maximize the similarity between source and target. TL-based methods have gained popularity over filter-based methods because the discarded instances may take away valuable information from the training projects.

Transfer Component Analysis (TCA) (Pan et al., 2010) is one of the pioneer method for TL that

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Hossain, M., Akhter, S., Islam, M., Alam, M. and Shoyaib, M. Can a Simple Approach Perform Better for Cross-Project Defect Prediction?. DOI: 10.5220/0012617300003687 Paper published under CC license (CC BY-NC-ND 4.0) In Proceedings of the 19th International Conference on Evaluation of Novel Approaches to Software Engineering (ENASE 2024), pages 328-335 ISBN: 978-989-758-696-5; ISSN: 2184-4895 Proceedings Copyright © 2024 by SCITEPRESS – Science and Technology Publications, Lda. finds a shared subspace to reduce the Maximum Mean Discrepancy (MMD) between the projected source and target project. TCA+ (Nam et al., 2013) introduced different types of normalization before applying TCA in CPDP. Two-Phase Transfer Learning (TPTL) (Liu et al., 2019) extends TCA+ by choosing the best suited source project from a set of given projects. Considering both marginal and conditional distributions Joint Distribution Adaptation (JDA) (Long et al., 2013) has been proposed which is further utilized by Balanced Distribution Adaptation (BDA) (Xu et al., 2019) for CPDP by balancing the importance of marginal and conditional distributions. Recently, Costsensitive Transfer Kernel Canonical Correlation Analysis (CTKCCA) (Li et al., 2018) and Joint Feature Representation with Double Marginalized Denoising Autoencoders (DMDA\_JFR) (Zou et al., 2021) have been proposed to solve class imbalance problem, capture nonlinear correlation and minimize distribution difference between target and source. In addition DMDA\_JFR reduces marginal and conditional distributions by preserving local and global feature structure as well and thus, ensures a reasonable performance.

All the aforementioned methods minimize either marginal or conditional or both distributions discrepancy between source and target. However, the minimization involves several parameters which are computationally expensive to tune. The minimization of conditional discrepancy requires pseudo labels of the target modules that might degrade the model performance (Zou et al., 2021). Moreover, these methods use symmetric transformation (i.e., they use same transformation for both source and target domain) that might ignore the similarity between source and target. One of the state-ofthe-art symmetric transformation-based method is CORrelation ALignment (CORAL) for domain adaptation (Sun et al., 2017) and is applied in CPDP (Niu et al., 2021) and heterogeneous CPDP (Li et al., 2019; Pal and Sillitti, 2022). The respective major goal of these paper is preprocessing of data prior to applying CORAL and extend it for heterogeneous CPDP. However, to the best of our knowledge, none of these papers investigate the strength of CORAL in comparison with standard transfer learning based methods for CPDP. In this paper, we thoroughly investigate CORAL for Cross-Project Defect Prediction (CCPDP), a computationally simple and parameter-free asymmetric approach, that is based on second order statistic (covariance) in comparison with the renowned transfer learning methods such as TCA, TCA+, JDA, BDA, CTKCCA

and DMDA\_JFR. The key contributions of this paper are listed below:

- 1. We provide a justification that a second order statistics can be applied for transfer learning in CPDP which can capture the shape and structure of data effectively and efficiently by utilizing a second order statistic.
- 2. We demonstrate the superiority of CCPDP by extensive experimentation over three benchmark datasets containing 46 project-pairs by comparing it with six transfer learning based methods.

## **2 PRELIMINARIES**

In this section, we have introduced the notations and objective function of CPDP approaches including TCA, TCA+, JDA, BDA, DMDA\_JFR and CTKCCA.

#### 2.1 Notations

We denote *m* as number of features and  $n_s$ ,  $n_t$  are numbers of modules (instances) in source and target project, respectively. Source project  $X_s \in \mathbb{R}^{n_s \times m}$  and its label  $Y_s \in \mathbb{R}^{n_s \times 1}$ . Target project  $X_t \in \mathbb{R}^{n_t \times m}$  and its label  $Y_t \in \mathbb{R}^{n_t \times 1}$ .  $X = X_s^T \cup X_t^T \in \mathbb{R}^{m \times (n_s + n_t)}$  is a combined project of source and target. *p* is the number of latent features. K, W, H, and *I* are kernel, projection, centering and identity matrix respectively.  $c \in \{1, 2, ..., C\}$  is distinct class label.  $M_c$  is classwise MMD matrix where  $(M_c)_{ij} = \frac{1}{n_s^{c^2}}$  if  $X_i, X_j \in X_s$ ;  $\frac{1}{n_t^{c^2}}$  if  $X_i, X_j \in X_t$ ;  $-\frac{1}{n_s^{c_1}r_t^c}$  if  $X_i \in X_s, X_j \in X_t$  or  $X_i \in$  $X_t, X_j \in X_s$ ; otherwise 0, and  $(M_0)_{ij} = \frac{1}{n_s^2}$  if  $X_i, X_j \in$  $X_s$ ;  $\frac{1}{n_t^2}$  if  $X_i, X_j \in X_t$ ; otherwise  $-\frac{1}{n_s n_t}$ .

## 2.2 TCA

TCA learns a nonlinear map  $\phi$  to project source modules  $X_{si} \in X_s$  and target modules  $X_{tj} \in X_t$  into a latent space to reduce squared MMD between them as defined in Eqn. (1).

Dist 
$$(\mathbf{X}_{s}, \mathbf{X}_{t}) = \| \frac{1}{n_{s}} \sum_{i=1}^{n_{s}} \phi(X_{si}) - \frac{1}{n_{t}} \sum_{j=1}^{n_{t}} \phi(X_{tj}) \|_{\mathcal{H}}^{2}$$
(1)

where  $\mathcal{H}$  denotes universal reproducing kernel Hilbert space. The objective function of TCA is defined in Eqn. (2).

$$\min_{W} tr(W^{T}KM_{0}KW) + \mu tr(W^{T}W), \qquad (2)$$
  
s.t.W<sup>T</sup>KHKW = I

where  $\mu$  is a regularization parameter,  $K = \begin{bmatrix} K_{SS} & K_{ST} \\ K_{TS} & K_{TT} \end{bmatrix}$  is a  $(n_s + n_t) \times (n_s + n_t)$  kernel matrix,  $K_{SS}$ ,  $K_{TT}$  and  $K_{ST}$  are the kernel matrices defined by kernel trick on the data in the source domain, target domain, and cross domains respectively and  $W \in \mathbb{R}^{(n_s+n_t)\times p}$  linearly transforms K to p dimensional space where  $p < n_s + n_t$ .

## 2.3 JDA

JDA minimizes differences in both marginal and conditional distributions between source and target simultaneously by optimizing Eqn. (3).

$$\min_{W^T X H X^T W = I} \sum_{c=0}^{C} tr(W^T X M_c X^T W) + \mu \| W \|_F^2 \quad (3)$$

where  $W \in \mathbb{R}^{m \times p}$ , and  $\mu$  is a regularization parameter.

#### 2.4 BDA

BDA uses a balance factor  $\mu$  to adaptively adjust the importance of both the marginal and conditional distributions. The objective is defined in Eqn. (4)

$$\min tr(W^{T}X((1-\mu)M_{0}+\mu\sum_{c=1}^{C}M_{c})X^{T}X+\lambda \|W\|_{F}^{2},$$
(4)
  
s.t.W^{T}XHX^{T}W=I, 0 \le \mu \le 1.

when  $\mu = 0$ , BDA only focuses on minimizing the marginal distribution, and when  $\mu = 1$ , it focuses on the conditional distribution.

## 2.5 CTKCCA

The objective of CTKCCA is to find  $W_s \in \mathbb{R}^{d \times p}$  and  $W_t \in \mathbb{R}^{d \times p}$ , where *d* is low rank feature approximation of *K*. The objective function is Eqn. (5)

$$\max_{w_s, w_t} w_s^T \tilde{G}_{ST} w_t$$
(5)  
s.t. $w_s^T \tilde{G}_{SS} w_s = 1, w_s^T \tilde{G}_{TT} w_t = 1.$ 

where  $w_i \in \mathbb{R}^d$  is a column vector,  $\tilde{G}_{SS} = \sum_{c=1}^C f(c) (\bar{G}_s^c)^T \bar{G}_s^c$ ,  $\tilde{G}_{TT} = \bar{G}_t^T \bar{G}_t$  and  $\tilde{G}_{ST} = \sum_{c=1}^C f(c) (\bar{G}_s^c)^T \Gamma_G^c \bar{G}_t$  are  $(d \times d)$  dimensional approximation of the kernel matrices  $K_{SS}$ ,  $K_{TT}$  and  $K_{ST}$ , respectively. f(c) describes the weight of the class c and  $\Gamma_G^c$  denotes the similarity weight between  $\bar{G}_s^c$  and  $\bar{G}_t$ .  $\bar{G}_i$  is mean centered  $G_i$ .

#### 2.6 DMDA\_JFR

DMDA\_JFR captures the global feature structure using Eqn. (6)

$$\min_{W} \frac{1}{2l(n_s+n_t)} tr[(X-W\tilde{X})^T(X-W\tilde{X})] + \mu \parallel W \parallel_F^2 
+ E_{mar}(\tilde{X}_s, \tilde{X}_t) + E_{con}(\tilde{X}_s, \tilde{X}_t).$$
(6)

where  $\mu$  is the regularization parameter,  $\tilde{X}$  denotes the corrupted version of X (Wei et al., 2018), l is the number of repeated version of X,  $E_{mar}(\tilde{X}_s, \tilde{X}_t)$  and  $E_{con}(\tilde{X}_s, \tilde{X}_t)$  match the marginal and the conditional cross-project distributions respectively.  $E_{mar}(\tilde{X}_s, \tilde{X}_t)$  is defined in Eqn. (7)

$$E_{mar}(\tilde{X}_s, \tilde{X}_t) = W^T \tilde{X}_s^T Z_{Sl} \tilde{X}_s W + W^T \tilde{X}_t^T Z_{Tl} \tilde{X}_t W - 2W^T \tilde{X}_s^T Z_{STl} \tilde{X}_t W.$$
(7)

where  $Z_{Sl} = \frac{1}{n_s^2} I_{n_s}$ ,  $Z_{Tl} = \frac{1}{n_t^2} I_{n_t}$ , and  $Z_{STl} = \frac{1}{n_s n_t} I_{n_s \times n_t}$ .  $E_{con}(\tilde{X}_s, \tilde{X}_t)$  is defined in Eqn. (8)

$$E_{con}(\tilde{X}_s, \tilde{X}_t) = W^T \tilde{X}_s^T Z_{Sl}^c \tilde{X}_s W + W^T \tilde{X}_t^T Z_{Tl}^c \tilde{X}_t W - 2W^T \tilde{X}_s^T Z_{STl}^c \tilde{X}_t W$$
(8)

To capture local structure with label c DMDA\_JFR follows Eqn. (9)

$$\frac{\min_{W} \frac{1}{2l(n_{s}+n_{t})_{c}} tr[(X_{c}-W_{c}\tilde{X}_{c})^{T}(X_{c}-W_{c}\tilde{X}_{c})]}{+\mu \|W_{c}\|_{F}^{2} + E_{mar}(\tilde{X}_{sc},\tilde{X}_{tc}).$$
(9)

where  $X_c = X_s^c \cup X_t^c$  the subset of class *c* data from both source and target domain.

# **3** APPROACH

It is well known that the utilization of covariance in transfer learning can efficiently capture the structure of data. (Zhang et al., 2020). This inspires us to adopt CORrelation ALignment (CORAL) for cross-project defect prediction.

# 3.1 Correlation Alignment for Cross-Project Defect Prediction

To capture domain structure using feature correlations, CCPDP follows correlation alignment to minimize distribution difference by aligning the second-order statistics, i.e., the covariance matrices of source and target projects without requiring any pseudo-label. The objective of CCPDP is to find a linear transformation matrix W that minimizes Frobenius norm defined as follows

$$\| W^T C_s W - C_t \|_F^2, \tag{10}$$



Figure 1: Overall process of CCPDP.

where  $C_s = \frac{1}{n_s - 1} X_s^T H_s X_s$  and  $C_t = \frac{1}{n_t - 1} X_t^T H_t X$  are the covariance matrices of source and target.  $H_s = I_{n_s \times n_s} - \frac{1}{n_s} \mathbf{11}^T$  and  $H_t = I_{n_t \times n_t} - \frac{1}{n_t} \mathbf{11}^T$  are the centering matrices.

To gain efficiency and stability the diagonal elements of both the covariance matrices are increased by 1 to make them full rank. It can be shown that  $W = C_s^{-\frac{1}{2}}C_t^{\frac{1}{2}}$ . Thus the final transformation  $(X'_s)$  of the source data can be described in two steps. First (Whitening), the feature correlations of the source is whitened following by the Eqn. (11)

$$X_h = X_s C_s^{-\frac{1}{2}}.$$
 (11)

Second (re-coloring), the transformed source  $(X'_s)$  is obtained by adding the correlation of the target to the whitened source  $(X_h)$  following Eqn. (12)

$$X_s' = X_h C_t^{\frac{1}{2}}.$$
 (12)

CCPDP requires standardization of source and target so that the features have zero mean ( $\mu$ ) and unit variance ( $\sigma^2$ ) which can be achieved by following Eqn. (13)

$$Z = \frac{X - \mu}{\sigma}.$$
 (13)

The overall process of CCPDP is depicted in Fig. 1 for AEEEM dataset where two features namely, 'number of attributes inherited' and 'number of methods' are presented in the ellipes. The unaligned source and target got aligned after applying CORAL following Eq. (11) and (12) prior to classification.

#### 3.2 Classification

The transformed source  $X'_s$  with label  $Y_s$  is used to train a classifier and the original target  $X_t$  is used for prediction  $Y'_t$ . As this approach only transforms source rather than target we refer it as an asymmetric transformation.

#### 3.3 Justification

We observe that there exist a second order discrepancy in CPDP problem. To understand this, let



Figure 2: Covariance plot (major points are bounded by ellipses) of two features from (a) RELINK and (b) AEEEM dataset. CCPDP properly aligns (right figure) the covariance discrepancy (left figures) for the two datasets.

us consider two project-pairs from RELINK (Apache-Safe) and AEEEM (EQ-LC) datasets, one as the source and other as the target. The left side ellipses in Fig. 2 represent the actual covariance found in the dataset which support our observation. If we apply CCPDP, we find the right side figure that corresponds to the aligned source with respect to the target. Such alignments inspires us to use second order statistics for CCPDP.

# **4 EXPERIMENTAL RESULTS**

In this section, we describe the datasets, implementation details and experimental results analysis of CCPDP along with six other state-ofthe-art CPDP methods: TCA, TCA+, JDA, BDA, DMDA\_JFR and CTKCCA, and answer the following two questions.

**RQ1.** Does CCPDP perform better than each of the mentioned state-of-the-art transfer learning based CPDP methods?

RQ2. Is the performance of CCPDP consistent?

#### 4.1 Dataset Description

In this study, extensive experiments have been performed on three benchmark datasets: AEEEM (D'Ambros et al., 2012), SOFTLAB (Menzies et al., 2012), and RELINK (Wu et al., 2011). The detailed information such as language (Lang.), granularity (Granul.), number of features, number of modules (Mod.), and percentage of defected modules (DM. %) are provided in the Table 1.

#### 4.2 Implementation Details

For each dataset, we first consider one of the projects as the source and the remaining projects as the target

| Dataset | Projects | Lang. | Granul.  | Mod.  | DM. (%) | Number of Features                   |  |  |
|---------|----------|-------|----------|-------|---------|--------------------------------------|--|--|
| AEEEM   | EQ       | Java  | Class    | 324   | 39.8    | 61(5(previous defect) +              |  |  |
|         | JDT      |       |          | 997   | 20.7    | 17 (source code) +                   |  |  |
|         | LC       |       |          | 691   | 9.3     | 17(entropy of source code) +         |  |  |
|         | ML       |       |          | 1,862 | 13.2    | 5(entropy of change)                 |  |  |
|         | PDE      |       |          | 1,497 | 14      | + 17(churn of source code)           |  |  |
| RELINK  | Apache   | Java  | File     | 194   | 50.5    | 26 (static code features (26)        |  |  |
|         | Safe     |       |          | 56    | 39.3    | e.g., maximum cyclomatic complexity, |  |  |
|         | Zxing    |       |          | 399   | 29.6    | average line comment,                |  |  |
|         |          |       |          |       |         | line of code count etc.)             |  |  |
| SOFTLAB | ar1      | С     | Function | 121   | 7.4     | 20 (static code features (20)        |  |  |
|         | ar3      |       |          | 63    | 12.7    | a g design complexity                |  |  |
|         | ar4      |       |          | 107   | 18.7    | halstead count                       |  |  |
|         | ar5      |       |          | 36    | 22.2    | automatic complexity etc.)           |  |  |
|         | ar6      | 1     |          | 102   | 14.7    | cyclomatic complexity, etc.)         |  |  |

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and repeat this process for the remaining projects. For example, there are five projects in the AEEEM dataset and we first considered EQ as source and all other as targets of EQ (EQ-JDT, EQ-LC, EQ-ML, EQ-PDE). Consequently, we obtain 46 (20+6+20) project-pairs for three datasets.

To compare the performance, we use Random Forest (RF) as a classifier for all methods and three metrics such as F1-score, Balance, and area under curve (AUC). Since software defect datasets are imbalanced, we calculate AUC for all methods. Balance is also well-known for SDP problems (Menzies et al., 2006; Sharmin et al., 2015). F1-score and Balance are computed following the Eqn. (14) and Eqn. (15), respectively

$$F1\text{-}score = \frac{TP}{TP + .5 * (FP + FN)}$$
(14)

Balance = 
$$1 - \frac{\sqrt{(1 - pd)^2 + (0 - pf)^2}}{\sqrt{2}}$$
, (15)

where TP is true positive, FN is false negative, FPis false positive and TN is true negative, and pd = $\frac{TP}{TP+FN} \text{ and } pf = \frac{FP}{FP+TN}.$ We measure the performances of each of the

methods over all pairs of projects in each dataset using the Friedman test. If we can reject the null hypothesis ( $H_0$  = "all methods perform equally in all datasets") using friedman test, we use a post-hoc test called the Nemenyi test (Nemenyi, 1963) to determine which method significantly perform better than the others. A method can be said significantly perform better than the others if the difference between their corresponding average rank is larger than a critical difference (CD) which is calculated using Eqn. (16).

$$CD = q_{\alpha} \sqrt{\frac{k(k+1)}{6N}},$$
 (16)

where N is the number of project-pairs for each dataset, k is the number of methods and  $q_{\alpha}$  is the critical value at  $\alpha$  (0.05 in our case) significance level. For fair comparisons, we keep the same setup for all the methods.

#### 4.3 **Result Discussion**

RQ1: Does CCPDP perform better than each of the mentioned state-of-the-art transfer learning based **CPDP** methods?

The results of all project-pairs (source-target) are demonstrated using radar plot as shown in Fig. 3. The axes in a radar plot illustrate the performances of the compared methods for individual project-pairs. For instance, AEEEM dataset has a total of five projects leading to a 20 different project-pairs (and hence there are 20 axes in the plot). The brown dot on the axis corresponding to the E-J pair in the radar plot of AEEEM dataset depicted in Fig. 3 (a) represents the F1-score 0.43 for CCPDP. The shaded region in a particular radar plot represents the maximum performance of CCPDP for all projectpairs considering a particular metric. A closer look at the plots reveals that the CCPDP wins for majority of the project-pairs in each dataset.

The summary of the radar plots for the selected performance metrics are presented in Tables 2-4 as Note that win/tie/loss indicates the win/tie/loss. number of project-pairs in a particular dataset for which CCPDP performs better/equally-well/worse than each of the compared methods. The tables also represent collective percentages of wins of CCPDP over the existing methods for individual metrics out of the 46 project-pairs. We find that the win range of CCPDP is 63%-91% and its average is 78.3%. **RQ2:** Is the Performance of CCPDP Consistent?



Figure 3: The figure displays nine different radar plots in three columns (each column represents a dataset). Each row represents the performance of compared methods based on a metric.

|           |          |          | F1-score |          |          |          |
|-----------|----------|----------|----------|----------|----------|----------|
|           | TCA      | TCA+     | JDA      | BDA      | CTKCCA   | DMDA_JFR |
| AEEEM     | 17/0/3   | 11/0/9   | 18/0/2   | 18/0/2   | 19/0/1   | 17/1/2   |
| RELINK    | 4/0/2    | 4/0/2    | 4/0/2    | 5/0/1    | 6/0/0    | 5/0/1    |
| SOFTLAB   | 13/1/6   | 14/1/5   | 13/1/6   | 14/0/6   | 15/3/2   | 12/0/8   |
| Total Win | 34 (74%) | 29 (63%) | 35 (76%) | 37 (80%) | 40 (87%) | 34 (74%) |

### Table 2: Win/Tie/Loss of CCPDP based on F1-score.

| Table 3: Win/Tie/Loss of CCPDP based on Balance. |          |          |          |          |          |          |  |  |
|--|----------|----------|----------|----------|----------|----------|--|--|
| Balance  |          |          |          |          |          |          |  |  |
|  | TCA      | TCA+     | JDA      | BDA      | CTKCCA   | DMDA_JFR |  |  |
| AEEEM  | 17/0/3   | 14/0/6   | 19/0/1   | 19/0/1   | 19/0/1   | 17/0/3   |  |  |
| RELINK   | 5/0/1    | 4/0/2    | 5/0/1    | 5/0/1    | 6/0/0    | 4/0/2    |  |  |
| SOFTLAB  | 13/1/6   | 15/1/4   | 14/1/5   | 14/0/6   | 16/2/2   | 10/0/10  |  |  |
| Total Win  | 35 (76%) | 33 (72%) | 38 (83%) | 38 (83%) | 41 (89%) | 31 (67%) |  |  |



Table 4: Win/Tie/Loss of CCPDP based on AUC.

Figure 4: Statistic results using Nemenyi test for CCPDP and six other methods in terms of three performance metrics F1-score (a,b,c), Balance (d,e,f) and AUC (g,h,i). Performances of methods connected by horizontal lines do not differ significantly.

We perform a significance test as mentioned before. After rejecting the null hypothesis, the ranking of the CCPDP and the compared methods are then calculated. Fig. 4 illustrates the outcomes of the Nemenyi test for F1-score, Balance and AUC metrics.  $H_0$  is rejected for all. Among nine tests (three for each dataset), CCPDP achieves rank-1 (first) and rank-2 (second) in eight and one cases, respectively. Even though CCPDP secured the second position in case of SOFTLAB dataset for AUC metric, its performance is not significantly different from DMDA\_JFR. Note that, although CCPDP performs better in most of the cases, many of the other methods do not significantly differ with CCPDP. However, those methods require high computational cost along with several tuning parameters. Therefore, we can conclude that CCPDP performs consistently better compared to existing methods at a lower computational cost.

# **5 THREATS TO VALIDITY**

It is shown that the utilization of correlation alignment makes CCPDP consistently better than other methods in three dataset. Due to the space limitation, we only considered a single classifier random forest and three popular metrics F1-score, Balance, and AUC to evaluate the performance. Therefore, a change in classifier such as decision tree, logistic regression and metrics such as g-measure and MCC might result in a different performance from the reported. Further, we use datasets that are widely considered for CPDP problem which includes 46 project-pairs. However, this number may not generalize our findings. Finally, though we have carefully implemented other methods and followed the parameter settings according to the suggestions of the respective paper, there might be a chance of obtaining slightly different results for the existing methods.

## 6 CONCLUSION

In this paper, we investigated a computationally simple and parameter-free transfer learning based method using CORAL for the cross-project defect prediction problem which will provide a relief for the users from the uncertainty of optimally tuning the parameters and achieving the best results. This also saves time and cost. Our CORAL based approach CCPDP outperforms existing methods in most of the cases. However, we observed that CORAL fails to align source and target in some cases which can be investigated in a future work.

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